

Notice of References Cited	Application/Control No. 10/510,634	Applicant(s)/Patent Under Reexamination HIKOMOTO, SATOMI	
	Examiner Bobbak Safaipour	Art Unit 2618	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0045445 A1	04-2002	Higuchi, Kazutoshi	455/425
*	B	US-2002/0045449 A1	04-2002	Oobayashi, Mamiko	455/436
*	C	US-2002/0183059 A1	12-2002	Noreen et al.	455/427
*	D	US-2003/0043775 A1	03-2003	Kikuchi, Tetsuya	370/342
*	E	US-2004/0102159 A1	05-2004	Suda et al.	455/067.11
*	F	US-2004/0203336 A1	10-2004	Sinnarajah et al.	455/003.01
*	G	US-7,054,592 B2	05-2006	Tatsumi et al.	455/3.06
*	H	US-2006/0111038 A1	05-2006	Tatsumi et al.	455/003.01
*	I	US-7,089,007 B2	08-2006	Wakuta et al.	455/436
*	J	US-2006/0245605 A1	11-2006	Matsunaga, Ayako	381/123
*	K	US-2002/0010763	01-2002	Salo et al.	709/220
*	L	US-5,822,324	10-1998	Kostresti et al.	370/487
*	M	US-7,054,592	05-2006	Tatsumi et al.	455/3.06

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.